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TRADEMAR	Gubstitute for form 1	1449/07		Application Number	09/726,903		
INFOR	RMATION DI EMENT BY	SCLC	SURE	Filing Date	11/29/2000		
SIAI	CIVICIAL DA	APPL	ICANI	First Named Inventor	Lee Pooi See, et al.		
(us	e as many sheets a	as neces	sary)	Group Art Unit	2823.		
				Examiner Name	Joannie A. Garcia		
Sheet	1	of	1	Attorney Docket Number	CHAR.P0003		

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